Search Notes	
	•
	>
	e
	a
	r
	C
	n
	ı
	٧
	(
)
	(
_	9
	S
	•

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/540,783	DUPUIS ET AL.	
Examiner	Art Unit	
David M. Brunsman	1755	

SEARCHED			
Class	Subclass	Date	Examiner
106	277 281.1 284.01	6/23/2006	DB
		·	

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
	<u> </u>			

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
eDan inventor name search	6/23/2006	DB	
		:	